



SPECIFICATION

- Supplier : Samsung electro-mechanics
- Product : Multi-layer Ceramic Capacitor
- Samsung P/N : CL10C681JB8NFNC
- Description : CAP, 680 pF, 50V, ±5%, C0G, 0603

A. Samsung Part Number

		<u>CL</u> ①		C <u>681</u> J 3 (4) (5)	<u>B8N</u>		
1	Series	Samsung Multi-layer Ceramic Capacitor					
2	Size	0603 (inch	code)	L: 1.0	6 ± 0.1 mm	W: 0.8 ± 0.1	mm
3	Dielectric	C0G		(8)	Inner electrode	Ni	
4	Capacitance	680 pF			Termination	Cu	
5	Capacitance	±5 %			Plating	Sn 100%	(Pb Free)
	tolerance			9	Product	Product for F	POWER application
6	Rated Voltage	50 V		10	Special	Reserved for	r future use
\bigcirc	Thickness	0.8 ± 0.1	mm	(1)	Packaging	Cardboard T	ype, 7" reel

B. Samsung Reliablility Test and Judgement condition

	Performance	Test condition				
Capacitance	Within specified tolerance	1₩±10% 0.5~5Vrms				
Q	1000 min					
Insulation	10,000Mohm or 500Mohm · μF	Rated Voltage 60~120 sec.				
Resistance	Whichever is Smaller					
Appearance	No abnormal exterior appearance	Microscope (×10)				
Withstanding	No dielectric breakdown or	300% of the rated voltage				
Voltage	mechanical breakdown					
Temperature	COG					
Characterisitcs	(From -55℃ to 125℃, Capacitance change shoud be within ±30PPM/℃)					
Adhesive Strength	No peeling shall be occur on the	500g·F, for 10±1 sec.				
of Termination	terminal electrode					
Bending Strength	Capacitance change :	Bending to the limit (1mm)				
	within $\pm 5\%$ or ± 0.5 pF whichever is larger	with 1.0mm/sec.				
Solderability	More than 75% of terminal surface	SnAg3.0Cu0.5 solder				
	is to be soldered newly	245±5℃, 3±0.3sec.				
		(preheating : 80~120 ℃ for 10~30sec.)				
Resistance to	Capacitance change :	Solder pot : 270±5℃, 10±1sec.				
Soldering heat	within $\pm 2.5\%$ or ± 0.25 pF whichever is larger					
	Tan δ, IR : initial spec.					

	Performance	Test condition			
Vibration Test	Capacitance change :	Amplitude : 1.5mm			
	within ±2.5% or ±0.25pF whichever is larger	From 10Hz to 55Hz (return : 1min.)			
	Tan δ, IR : initial spec.	2hours \times 3 direction (x, y, z)			
Moisture	Capacitance change :	With rated voltage			
Resistance	within ±7.5% or ±0.75pF whichever is larger	40±2℃, 90~95%RH, 500+12/-0hrs			
	Q : 200 min				
	IR : 500Mohm or 25Mohm · μF				
	Whichever is Smaller				
High Temperature	Capacitance change :	With 200% of the rated voltage			
Resistance	within ±3% or ±0.3pF whichever is larger	Max. operating temperature			
	Q : 350 min	1000+48/-0hrs			
	IR : 1000Mohm or 50Mohm · <i>μ</i> F				
	Whichever is Smaller				
Temperature	Capacitance change :	1 cycle condition			
Cycling	within ±2.5% or ±0.25pF whichever is larger	Min. operating temperature \rightarrow 25 °C			
	Tan δ, IR : initial spec.	\rightarrow Max. operating temperature \rightarrow 25 °C			
		5 cycle test			

C. Recommended Soldering method :

Reflow (Reflow Peak Temperature : 260+0/-5 $^\circ\!\mathrm{C}$, 10sec. Max)

* For the more detail Specification, Please refer to the Samsung MLCC catalogue.